

3.3 V 3.2 Gb/s Dual Differential Clock/Data 2 x 2 Crosspoint Switch with CML Output and Internal Termination

NB4N840M

Description

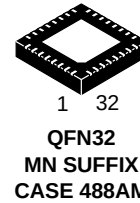
The NB4N840M is a high-bandwidth fully differential dual 2 x 2 crosspoint switch with CML inputs/outputs that is suitable for applications such as SDH/SONET, DWDM, Gigabit Ethernet and high speed switching. Fully differential design techniques are used to minimize jitter accumulation, crosstalk, and signal skew, which make this device ideal for loop-through and protection channel switching applications.

Internally terminated differential CML inputs accept AC-coupled LVPECL (Positive ECL) or direct coupled CML signals. By providing internal 50 Ω input and output termination resistor, the need for external components is eliminated and interface reflections are minimized. Differential 16 mA CML outputs provide matching internal 50 Ω terminations, and 400 mV output swings when externally terminated, 50 Ω to V_{CC} .

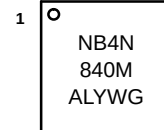
Single-ended LVCMOS/LVTTL SEL inputs control the routing of the signals through the crosspoint switch which makes this device configurable as 1:2 fan-out, repeater or 2 x 2 crosspoint switch. The device is housed in a low profile 5 x 5 mm 32-pin QFN package.

Features

- Plug-in compatible to the MAX3840 and SY55859L
- Maximum Input Clock Frequency 2.7 GHz
- Maximum Input Data Frequency 3.2 Gb/s
- 225 ps Typical Propagation Delay
- 80 ps Typical Rise and Fall Times
- 7 ps Channel to Channel Skew
- 430 mW Power Consumption
- < 0.5 ps RMS Jitter
- 7 ps Peak-to-Peak Data Dependent Jitter
- Power Saving Feature with Disabled Outputs
- Operating Range: $V_{CC} = 3.0\text{ V}$ to 3.6 V with $V_{EE} = 0\text{ V}$
- CML Output Level (400 mV Peak-to-Peak Output), Differential Output
- These are Pb-Free Devices



MARKING DIAGRAM



A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
G = Pb-Free Package

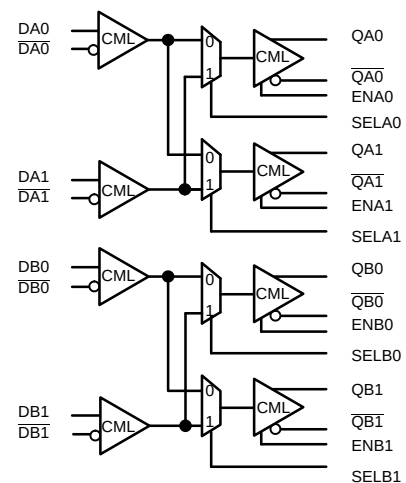


Figure 1. Functional Block Diagram

ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

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Table 1. TRUTH TABLE

SELA0/SELB0	SELA1/SELB1	ENA0/ENA1	ENB0/ENB1	QA0/QB0	QA1/QB1	Function
L	L	H	H	DA0/DB0	DA0/DB0	1:2 Fanout
L	H	H	H	DA0/DB0	DA1/DB1	Quad Repeater
H	L	H	H	DA1/DB1	DA0/DB0	Crosspoint Switch
H	H	H	H	DA1/DB1	DA1/DB1	1:2 Fanout
X	X	L	L	Disable/Power Down	Disable/Power Down	No output (@ V _{CC})

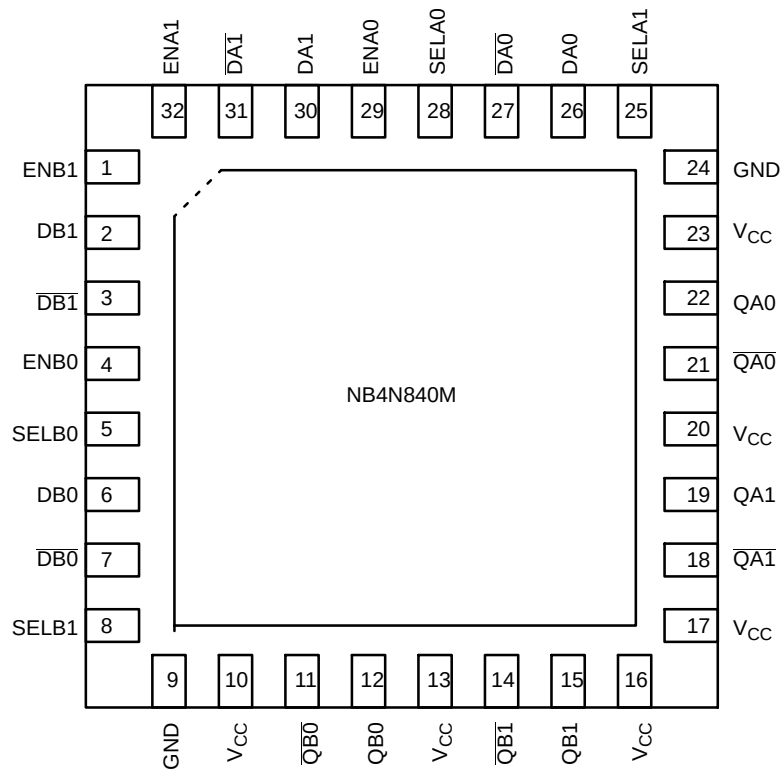


Figure 2. Pin Configuration (Top View)

Table 2. PIN DESCRIPTION

Pin	Name	I/O	Description
1	ENB1	LVTTL	Channel B1 Output Enable. LVTTL low input powers down B1 output stage.
2	DB1	CML Input	Channel B1 Positive Signal Input
3	$\overline{DB1}$	CML Input	Channel B1 Negative Signal Input
4	ENB0	LVTTL	Channel B0 Output Enable. LVTTL low input powers down B0 output stage.
5	SELB0	LVTTL	Channel B0 Output Select. See Table 1.
6	DB0	CML Input	Channel B0 Positive Signal Input
7	$\overline{DB0}$	CML Input	Channel B0 Negative Signal Input
8	SELB1	LVTTL	Channel B1 Output Select. See Table 1.
9,24	GND	–	Supply Ground. All GND pins must be externally connected to power supply to guarantee proper operation.
10, 13, 16, 17, 20, 23	V _{CC}	–	Positive Supply. All V _{CC} pins must be externally connected to power supply to guarantee proper operation.
11	$\overline{QB0}$	CML Output	Channel B0 Negative Output.
12	QB0	CML Output	Channel B0 Positive Output.
14	$\overline{QB1}$	CML Output	Channel B1 Negative Output.
15	QB1	CML Output	Channel B1 Positive Output.
18	$\overline{QA1}$	CML Output	Channel A1 Negative Output.
19	QA1	CML Output	Channel A1 Positive Output.
21	$\overline{QA0}$	CML Output	Channel A0 Negative Output.
22	QA0	CML Output	Channel A0 Positive Output.
25	SELA1	LVTTL	Channel A1 Output Select, LVTTL Input. See Table 1.
26	DA0	CML Input	Channel A0 Positive Signal Input.
27	$\overline{DA0}$	CML Input	Channel A0 Negative Signal Input.
28	SELA0	LVTTL	Channel A0 Output Select, LVTTL Input. See Table 1.
29	ENA0	LVTTL	Channel A0 Output Enable. LVTTL low input powers down A0 output stage.
30	DA1	CML Input	Channel A1 Positive Signal Input.
31	$\overline{DA1}$	CML Input	Channel A1 Negative Signal Input.
32	ENA1	LVTTL	Channel A1 Output Enable. LVTTL low input powers down A1 output stage.
–	EP	GND	Exposed Pad. The thermally exposed pad (EP) on package bottom (see case drawing) must be attached to a heat-sinking conduit. The exposed pad must be soldered to the circuit board GND for proper electrical and thermal operation.

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Table 3. ATTRIBUTES

Characteristics	Value
ESD Protection Human Body Model Machine Model	> 2000 V > 110 V
Moisture Sensitivity (Note 1) QFN-32	Level 1
Flammability Rating Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in
Transistor Count	380
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test	

1. For additional information, refer to Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V _{CC}	Positive Power Supply	GND = 0 V		3.8	V
V _I	Positive Input	GND = 0 V	GND = V _I = V _{CC}	3.8	V
V _{INPP}	Differential Input Voltage D - $\bar{D}$			3.8	V
I _{IN}	Input Current Through Internal 50 Ω Resistor	Static Surge		45 80	mA mA
I _{OUT}	Output Current	Continuous Surge		25 80	mA mA
T _A	Operating Temperature Range	QFN-32		-40 to +85	°C
T _{stg}	Storage Temperature Range			-65 to +150	°C
θ_{JA}	Thermal Resistance (Junction-to-Ambient) (Note 2)	0 lfpm 500 lfpm	QFN-32 QFN-32	31 27	°C/W °C/W
θ_{JC}	Thermal Resistance (Junction-to-Case)	2S2P (Note 3)	QFN-32	12	°C/W
T _{sol}	Wave Solder Pb-Free	<3 sec @ 260 C		260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

2. JEDEC standard 51-6, multilayer board - 2S2P (2 signal, 2 power).

3. JEDEC standard multilayer board - 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

Table 5. DC CHARACTERISTICS, CLOCK INPUTS, CML OUTPUTS $V_{CC} = 3.0\text{ V to }3.6\text{ V}$, $T_A = -40^\circ\text{C to }+85^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Unit
I_{CC}	Power Supply Current (All outputs enabled)		130	170	mA
V_{out_diff}	CML Differential Output Swing (Note 4, Figures 5 and 12)	640	800	1000	mV
V_{CMR} (Note 6)	CML Output Common Mode Voltage (Loaded $50\ \Omega$ to V_{CC})		$V_{CC} - 200$		mV
	CML Single-Ended Input Voltage Range	$V_{CC} - 800$		$V_{CC} + 400$	mV
V_{ID}	Differential Input Voltage ($V_{IHD} - V_{ILD}$)	300		1600	mV

LVTTL CONTROL INPUT PINS

V_{IH}	Input HIGH Voltage (LVTTL Inputs)	2000			mV
V_{IL}	Input LOW Voltage (LVTTL Inputs)			800	mV
I_{IH}	Input HIGH Current (LVTTL Inputs)	-10		10	μA
I_{IL}	Input LOW Current (LVTTL Inputs)	-10		10	μA
R_{TIN}	CML Single-Ended Input Resistance	42.5	50	57.5	Ω
R_{TOUT}	Differential Output Resistance	85	100	115	Ω

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm.

4. CML outputs require $50\ \Omega$ receiver termination resistors to V_{CC} for proper operation (Figure 10).

5. Input and output parameters vary 1:1 with V_{CC} .

6. V_{CMR} min varies 1:1 with V_{EE} , V_{CMR} max varies 1:1 with V_{CC} .

Table 6. AC CHARACTERISTICS $V_{CC} = 3.0\text{ V to }3.6\text{ V}$, $V_{EE} = 0\text{ V}$ (Note 7, Figure 9)

Symbol	Characteristic	-40°C			25°C			85°C			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
V_{OUTPP}	Output Voltage Amplitude (@ $V_{INPPmin}$) (See Figure 3) $f_{in} \leq 2\text{ GHz}$ $f_{in} \leq 3\text{ GHz}$ $f_{in} \leq 3.5\text{ GHz}$	280 235 170	365 310 220		280 235 170	365 310 220		280 235 170	365 310 220		mV
f_{DATA}	Maximum Operating Data Rate	3.2			3.2			3.2			Gb/s
t_{PLH} , t_{PHL}	Propagation Delay to Output Differential $D/\bar{D}$ to $Q/\bar{Q}$	140	225	340	140	225	340	140	225	340	ps
t_{SKEW}	Duty Cycle Skew (Note 8) Within-Device Skew (Figure 4) Device-to-Device Skew (Note 12)		5 5 20	25 25 85		5 5 20	25 25 85		5 5 20	25 25 85	ps
t_{JITTER}	RMS Random Clock Jitter (Note 10) $f_{in} \leq 3.2\text{ GHz}$ Peak-to-Peak Data Dependent Jitter $f_{in} = 2.5\text{ Gb/s}$ (Note 11) $f_{in} = 3.2\text{ Gb/s}$		0.15 7 7	0.5 20 20		0.15 7 7	0.5 20 20		0.15 7 7	0.5 20 20	ps
	Crosstalk-Induced RMS Jitter (Note 13)			0.5			0.5			0.5	ps
V_{INPP}	Input Voltage Swing/Sensitivity (Differential Configuration) (Note 9)	150		800	150		800	150		800	mV
t_r , t_f	Output Rise/Fall Times @ 0.5 GHz (20% – 80%) $Q, \bar{Q}$		80	135		80	135		80	135	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm.

7. Measured by forcing V_{INPP} (MIN) from a 50% duty cycle clock source. All loading with an external $R_L = 50\ \Omega$ to V_{CC} . Input edge rates 40 ps (20% – 80%).

8. Duty cycle skew is measured between differential outputs using the deviations of the sum of T_{pw-} and T_{pw+} @ 0.5 GHz.

9. V_{INPP} (MAX) cannot exceed 800 mV. Input voltage swing is a single-ended measurement operating in differential mode.

10. Additive RMS jitter using 50% duty cycle clock input signal.

11. Additive peak-to-peak data dependent jitter using input data pattern with PRBS 2²³-1 and K28.5, $V_{INPP} = 400\text{ mV}$.

12. Device to device skew is measured between outputs under identical transition @ 0.5 GHz.

13. Data taken on the same device under identical condition.

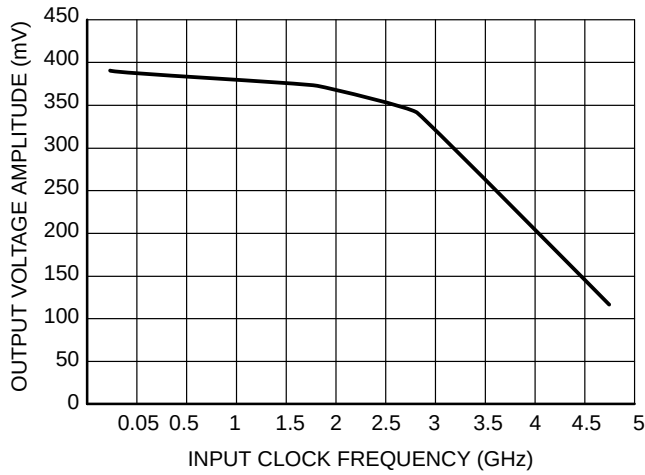


Figure 3. Output Voltage Amplitude (V_{OUTPP}) vs. Input Clock Frequency (f_{IN}) at Ambient Temperature (Typ)

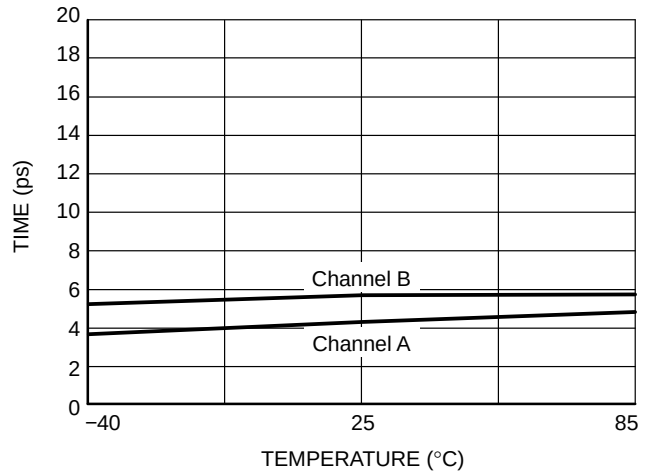


Figure 4. Within-Device Skew vs. Temperature at $V_{CC} = 3.3$ V

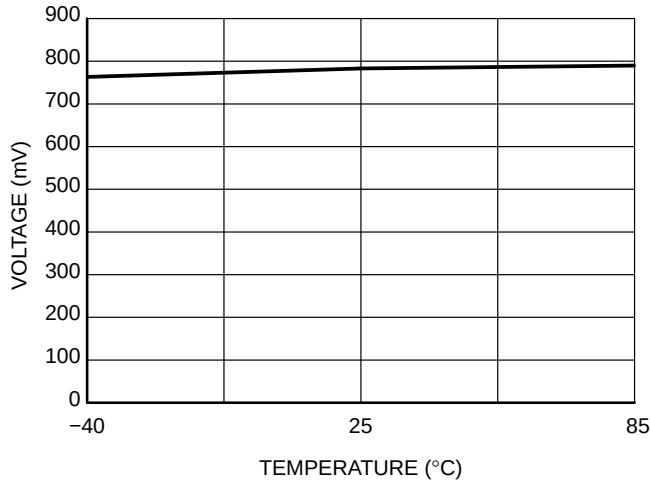


Figure 5. CML Differential Voltage vs. Temperature

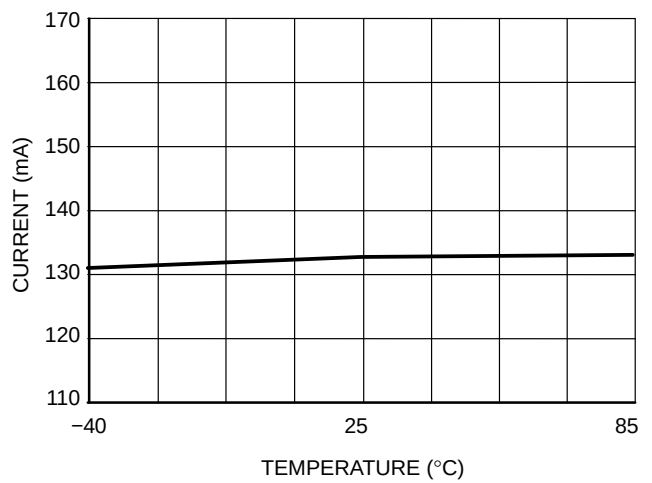


Figure 6. Supply Current vs. Temperature (All 4 Outputs Enabled)

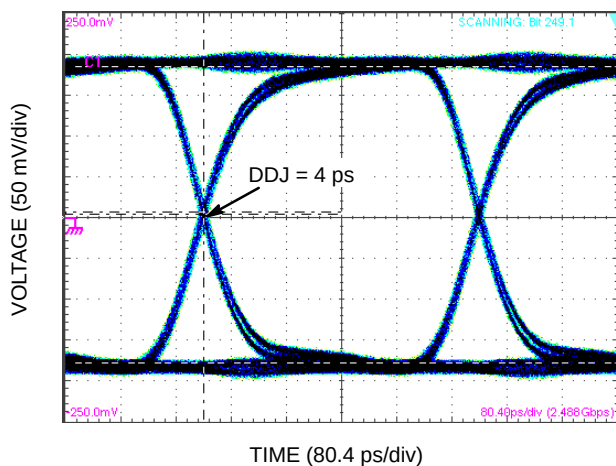


Figure 7. Typical Output Waveform at 2.488 Gb/s with PRBS 2²³-1 (Input Signal DDJ = 12 ps)

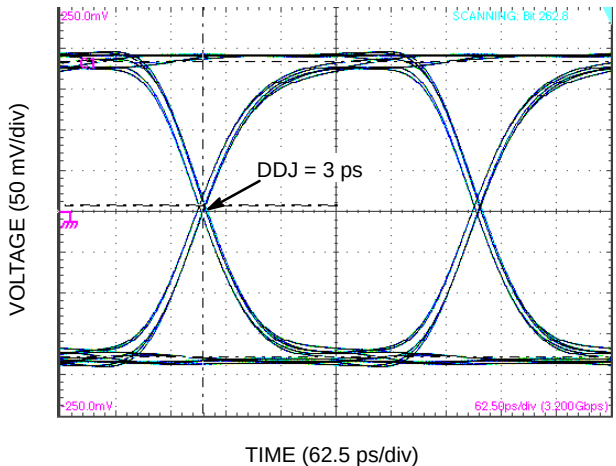


Figure 8. Typical Output Waveform at 3.2 Gb/s with K28.5 (Input Signal DDJ = 14 ps)

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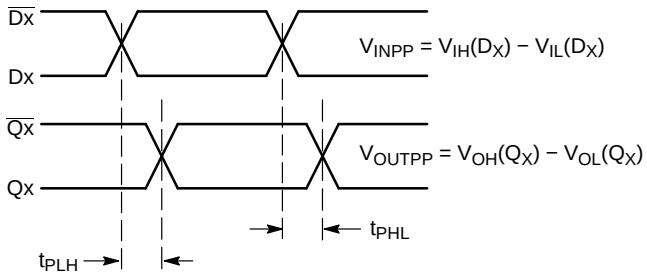


Figure 9. AC Reference Measurement

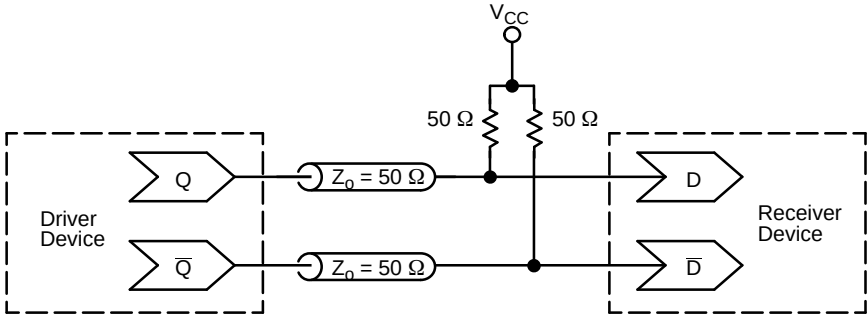


Figure 10. Typical Termination for Output Driver and Device Evaluation
(See Application Note AND8173/D)

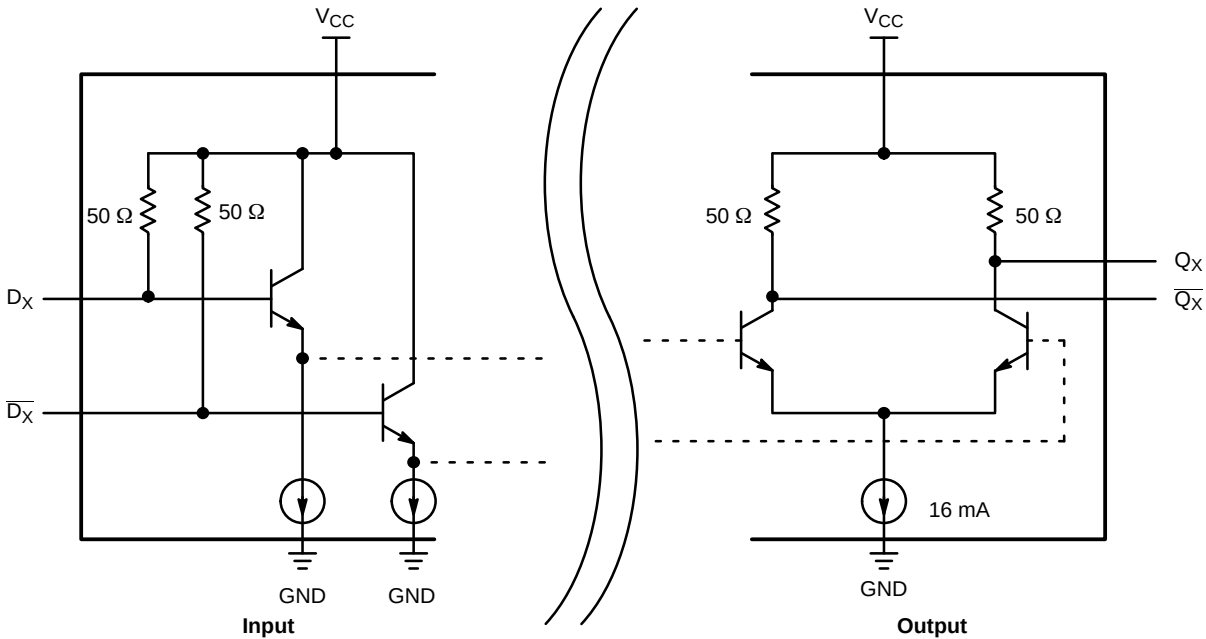


Figure 11. CML Input and Output Structure

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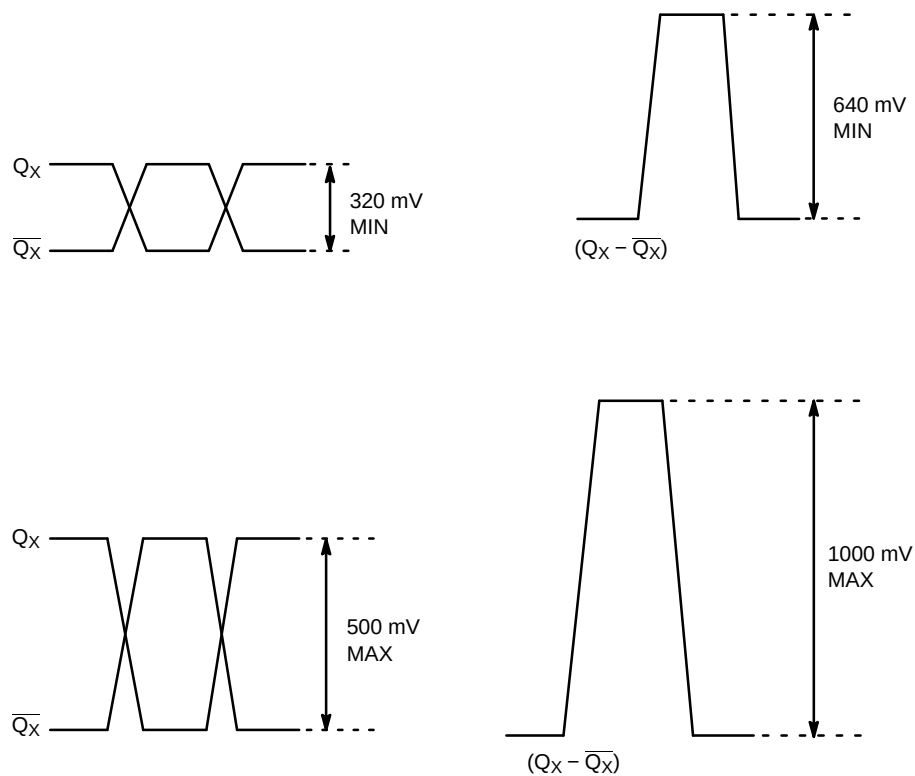
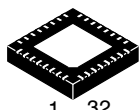


Figure 12. CML Output Levels

ORDERING INFORMATION

Device	Package	Shipping
NB4N840MMNG	QFN32 (Pb-Free)	74 Units / Rail
NB4N840MMNR4G	QFN32 (Pb-Free)	1000 / Tape & Reel

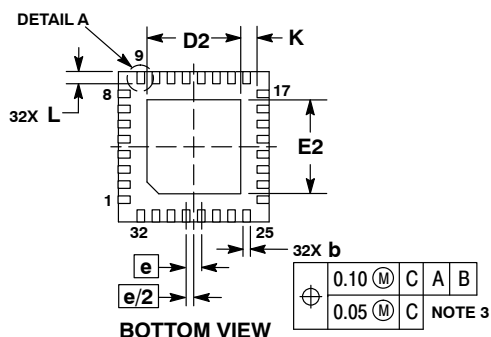
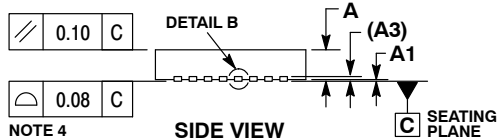
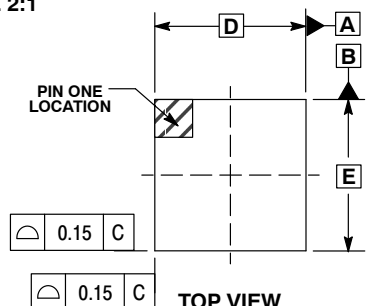
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



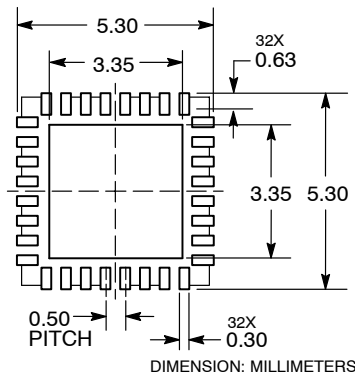
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SCALE 2:1

QFN32 5x5, 0.5P CASE 488AM ISSUE A

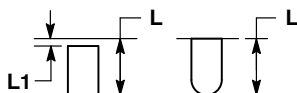
DATE 23 OCT 2013



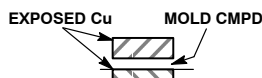
RECOMMENDED SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



DETAIL A
ALTERNATE TERMINAL
CONSTRUCTIONS



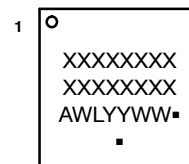
DETAIL B
ALTERNATE
CONSTRUCTION

NOTES:

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

MILLIMETERS		
DIM	MIN	MAX
A	0.80	1.00
A1		0.05
A3	0.20 REF	
b	0.18	0.30
D	5.00 BSC	
D2	2.95	3.25
E	5.00 BSC	
E2	2.95	3.25
e	0.50 BSC	
K	0.20	
L	0.30	0.50
L1		0.15

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "▪", may or may not be present.

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DESCRIPTION:	QFN32 5x5 0.5P	PAGE 1 OF 1

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